Features

- Current-controlled Output Current Source, 3 Input Channels
- Two Selectable Outputs for Grounded Laser Diodes
- Output Current per Channel up to 250 mA
- Total Output Current to 300 mA (Minimum)
- Rise Time 1.0 ns, Fall Time 1.1 ns
- On-chip RF Oscillator
- Control of 2 Different Swings by Use of 2 external Resistors
- Oscillator Frequency Range from 200 MHz to 600 MHz
- Oscillator Swing to 100 mA
- Single 5 V Power Supply
- Common Enable/Disable Input
- TTL/CMOS Control Signals
- Small SSO16 Package

Applications

- DVD-ROM with CD-RW Capability (Combo Drives)
- Combo Drives with CD and DVD Writing Capability

Description

The T0806 is a laser diode driver for the operation of two different grounded laser diodes for DVD-RAM (650 nm) and CD-RW (780 nm) drives. It includes three channels for three different optical power levels which are controlled by a separate IC. The read channel generates a continuous output level whereas channels 2 and 3 are provided as write channels with very fast switching speeds. Write current pulses are enabled when a low signal is applied to the NE pins. All channels are summed together and switched to one of the two outputs IOUTA or IOUTB by the select input SELA. Each channel can contribute up to 250 mA to the total output current of up to 300 mA. A total gain of 100 is provided between each reference current input and the selected output. Although the reference inputs are current inputs, voltage control is possible by using external resistors.

An on-chip RF oscillator is provided to reduce laser mode hopping noise during read mode. Swing can be set independently for the two selectable outputs with two different resistors. Oscillation is enabled by a high signal at the ENOSC pin. Complete output current and oscillator switch-off is achieved by a 'low' signal at the ENABLE input.



3-Channel Laser Driver with RF Oscillator and 2 Outputs

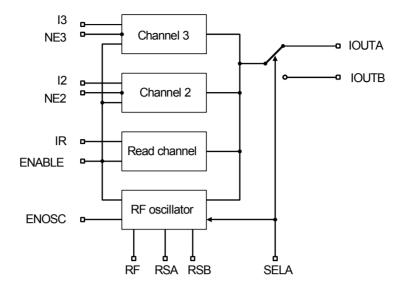
T0806

Rev. 4522C-DVD-01/03

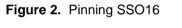


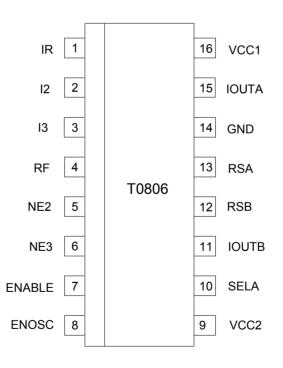


Figure 1. Block Diagram



Pin Configuration





T0806

Pin	Symbol	Туре	Function
1	IR	analog	Input current, bias voltage approximately GND
2	12	analog	Input current, bias voltage approximately GND
3	13	analog	Input current, bias voltage approximately GND
4	RF	analog	External resistor to GND sets oscillator frequency of oscillator A
5	NE2	digital	Digital control of channel 2 (low active)
6	NE3	digital	Digital control of channel 3 (low active)
7	ENABLE	digital	Enables output current (high active)
8	ENOSC	digital	Enables RF oscillator (high active)
9	VCC2	supply	+ 5 V power supply for IOUT
10	SELA	digital	High: selects IOUTA, RSA Low: selects IOUTB, RSB
11	IOUTB	analog	Output current source B for laser diode
12	RSB	analog	External resistor to GND sets swing of oscillator B
13	RSA	analog	External resistor to GND sets swing of oscillator A
14	GND	supply	Ground
15	IOUTA	analog	Output current source A for laser diode
16	VCC1	supply	+ 5 V power supply for IOUT and circuit

Absolute Maximum Ratings

Parameters	Symbol	Value	Unit
Supply voltage	V _{cc}	-0.5 to +6.0	V
Input voltage at IR, I2, I3	V _{IN1}	-0.5 to +1.0	V
Input voltage at NE2, NE3, ENOSC	V _{IN2}	–0.5 to V _{CC} +0.5	V
Output voltage	V _{OUT}	-0.5 to V _{CC} -1	V
Total output current	I _{OUT}	350	mA
Output current per channel	I _{OUT (IR, I2, I3)}	300	mA
Power dissipation	P _{MAX}	0.7 ⁽¹⁾ to 1 ⁽²⁾	W
Junction temperature	TJ	150	°C
Storage temperature range	T _{Stg}	-65 to +125	°C

Thermal Resistance

Parameters	Symbol	Value	Unit
Junction ambient	R _{thJA}	135	K/W





Recommended Operating Conditions

Parameters	Symbol	Value	Unit
Supply voltage range	V _{cc}	4.5 to 5.5	V
Input current	I _{IR} /I _{I2} /I _{I3}	< 3.0	mA
External resistor to GND to set oscillator frequency	RF	> 3	kΩ
External resistor to GND to set oscillator swing	RSA, RSB	> 1	kΩ
Operating temperature range	T _{amb}	0 to +70	٥C

Electrical Characteristics: General

 V_{CC} = 5 V, T_{amb} = 25°C, ENABLE = High, NE2 = NE3 = High, ENOSC = Low, unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
1	Power Supply						+		+
1.1	Supply current, power down	ENABLE = Low, NE2 = NE3 = Low	9, 16	ICC _{PD2}		0.3		mA	A
1.2	Supply current, read mode, oscillator disabled	$I_{IR} = I_{I2} = I_{I3} = 500 \ \mu A$	9, 16	ICC _{R1}		90		mA	A
1.3	Supply current, read mode, oscillator enabled, output A, selected	$I_{IR} = I_{I2} = I_{I3} = 500 \ \mu\text{A},$ ENOSC = High, RS = 7.5 kΩ, RF = 7.5 kΩ, SELA = High	9, 16	ICC _{R2}		93		mA	A
1.4	Supply current, write mode	$I_{IR} = I_{I2} = I_{I3} = 500 \ \mu\text{A},$ NE2 = NE3 = Low	9, 16	ICCw		180		mA	A
1.5	Supply current, input off	$I_{IR} = I_{I2} = I_{I3} = 0 \ \mu A$	9, 16	ICC _{off}		17		mA	A
2	Digital Inputs	1		1			1		4
2.1	NE2/NE3 low voltage		5, 6	VNE LO			1.3	V	А
2.2	NE2/NE3 high voltage		5, 6	VNE _{HI}	2.0			V	А
2.3	SELA low voltage		10	VSELA _{LO}			0.5	V	А
2.4	SELA high voltage		10	VSELA _{HI}	3.0			V	А
2.5	ENABLE low voltage		7	VEN _{LO}			0.5	V	А
2.6	ENABLE high voltage		7	VEN _{HI}	2.7			V	А
2.7	ENOSC low voltage		8	VEO _{LO}			0.5	V	А
2.8	ENOSC high voltage		8	VEO _{HI}	3.0			V	А
3	Current at Digital Inpu	ts							
3.1	NE2/NE3 low current	NE = 0 V	5, 6	INE _{LO}	-300			μA	А
3.2	NE2/NE3 high current	NE = 5 V	5, 6	INE _{HI}			800	μA	А
3.3	SELA low current	SELA = 0 V	10	ISELA _{LO}	-50			μA	А
3.4	SELA high current	SELA = 5 V	10	ISELA _{HI}			150	μA	А
3.5	ENABLE low current	ENABLE = 0 V	7	IEN _{LO}	-150			μA	Α

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

T0806

Electrical Characteristics: General (Continued)

V_{CC} = 5 V, T_{amb} = 25°C, ENABLE = High, NE2 = NE3 = High, ENOSC = Low, unless otherwise specified.

	unio	-	-						
No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
3.6	ENABLE high current	ENABLE = 5 V	7	IEN _{HI}			100	μA	А
3.7	ENOSC low current	ENOSC = 0 V	8	IEO _{LO}	-100			μA	А
3.8	ENOSC high current	ENOSC = 5 V	8	IEO _{HI}			800	μA	А

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Electrical Characteristics: Laser Amplifier

$V_{CC} = 5 V, T_{amb}$	= 25°C,	ENABLE =	High, unless	otherwise	specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
4	Outputs IOUTA and IO	UTB		1			L		
4.1	Total output current	Output is sourcing	11, 15	I _{OUT}	300	350		mA	А
4.2	Output current per channel	Output is sourcing	11, 15	I _{OUTR}	250			mA	A
4.3	Best fit current gain	Any channel ⁽¹⁾	11, 15	GAIN	90	100	130	mA/mA	А
4.4	Best fit current offset	Any channel ⁽¹⁾	11, 15	IOS	-8		+4	mA	А
4.5	Output current linearity	Any channel ⁽¹⁾	11, 15	ILIN	-3		+3	%	А
4.6	I _{IN} input impedance	R _{IN} is to GND	1, 2, 3	R _{IN}	150	200	250	Ω	А
4.7	NE threshold	Temperature stabilized	5, 6	VTH		1.68		V	С
4.8	Output off current 1	ENABLE = Low	11, 15	IOFF ₁			1	mA	А
4.9	Output off current 2	NE2 = NE3 = High, $I_{1R} = 0 \ \mu A$, $I_{12} = I_{13} = 500 \ \mu A$	11, 15	IOFF ₂			1	mA	A
4.10	Output off current 3	NE2 = NE3 = Low, I _{IR} = I _{I2} = I _{I3} = 0 µA	11, 15	IOFF ₃			5	mA	А
4.11	I _{OUT} supply sensitivity, read mode	$I_{OUT} = 40 \text{ mA},$ $V_{CC} = 5 \text{ V} \pm 10\%,$ read only	11, 15	VSE _R	-5		+1	%/V	A
4.12	I _{OUT} supply sensitivity, write mode	$I_{OUT} = 80 \text{ mA}, 40 \text{ mA}$ read + 40 mA write, $V_{CC} = 5 \text{ V} \pm 10\%$	11, 15	VSE _W	-6		0	%/V	A
4.13	I _{OUT} current output noise	I _{OUT} = 40 mA, ENOSC = Low	11, 15	INO _O		3		nA/rt-Hz	С
4.14	I _{OUT} temperature sensitivity, read mode	I _{OUT} = 40 mA, read only	11, 15	TSE _R		500		ppm/°C	С
4.15	I _{OUT} temperature sensitivity, write mode	I _{OUT} = 80 mA, 40 mA read + 40 mA write	11, 15	TSE _W		500		ppm/°C	С

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Note: 1. Linearity of the amplifier is calculated using a best fit method at three operating points of

 I_{OUT} at 20 $\,$ mA, 40 mA, and 60 mA. I_{OUT} = (I_{IN} × GAIN) + I_{OS}





Electrical Characteristics: Laser Amplifier AC Performance

$V_{ab} = \pm 5 V I_{ab} = 40 \text{ mA DC}$ with 40 mA	pulse, $T_A = 25^{\circ}C$ unless otherwise specified.
$v_{CC} = + 3 v$, $v_{OUT} = +0 mA DC with +0 mA$	pulse, $T_A = 25$ C unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Туре
5	Outputs IOUTA and IO	OUTB, AC Performance							1
5.1	Write rise time	I _{OUT} = 40 mA (read) + 40 mA (10% to 90%) ⁽¹⁾	11, 15	t _{RISE}		1.0	2.0	ns	С
5.2	Write fall time	I _{OUT} = 40 mA (read) + 40 mA (10% to 90%) ⁽¹⁾	11, 15	t _{FALL}		1.1	2.0	ns	С
5.3	Output current overshoot	$I_{OUT} = 40 \text{ mA (read)} + 40 \text{ mA}^{(1)}$	11, 15	OS		5		%	С
5.4	I _{OUT} ON propagation delay	NE 50% High-Low to I _{OUT} at 50% of final value	11, 15	t _{ON}		2		ns	С
5.5	I _{OFF} OFF propagation delay	NE 50% Low-High to I _{OUT} at 50% of final value	11, 15	t _{OFF}		2		ns	С
5.6	Disable time	ENABLE 50% High- Low to I _{OUT} at 50% of final value	11, 15	t _{DIS}		20		ns	С
5.7	Enable time	ENABLE 50% Low- High to I _{OUT} at 50% of final value	11, 15	t _{EN}		20		ns	С
5.8	SELA delay	SELA 50% Low-High to I _{OUT} at 50% of final value	11, 15	T _{SAH}		20			С
5.9	SELA delay	SELA 50% High-Low to I _{OUT} at 50% of final value	11, 15	T _{SAL}		20			С
5.10	Amplifier bandwidth	I _{OUT} = 50 mA, all channels, –3 dB value	11, 15	BW_{LCA}		16		MHz	С
6	Oscillator	<u> </u>					1	-	
6.1	Oscillator frequency	RF = 7.5 kΩ	11, 15	Fosc	270	300	330	MHz	Α
6.2	Oscillator temperature coefficient	RF = 7.5 kΩ	11, 15	TC _{OSC}		-150		ppm/°C	С
6.3	Disable time oscillator	ENOSC 50% High-Low to I _{OUT} , at 10%/90% of final value	11, 15	T _{DISO}		4		ns	С
6.4	Enable time oscillator	ENOSC 50% Low-High to I _{OUT} , at 10%/90% of final value	11, 15	T _{ENO}		2		ns	С

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Note: 1. Load resistor at IOUT 6.8 Ω , measurement with 50- Ω oscilloscope and 39- Ω series resistor.

6

Characteristics Curves

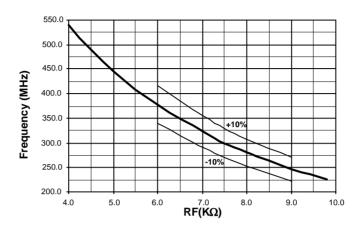


Figure 3. Oscillator Frequency vs. Resistor RF (RS = 7.5 k Ω)

Figure 4. Oscillator Swing vs. Resistor RS (RF = $7.5 \text{ k}\Omega$)

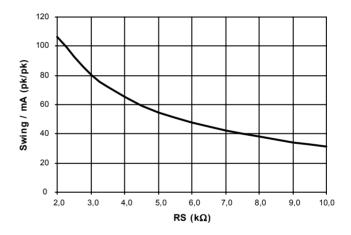


Figure 5. Oscillator Frequency Dependency of Swing

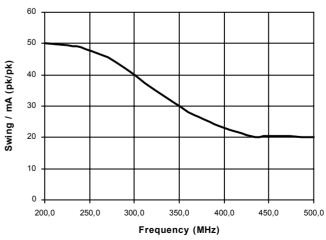




Figure 6. Transfer Characteristic of all Channels (Gain = 110.7)

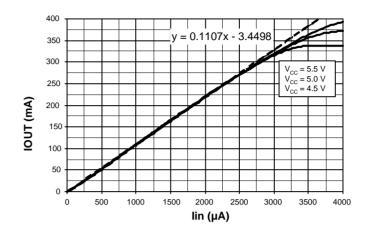


Figure 7. Voltage Compliance R (IOUT to VCC)= 5.9 Ω

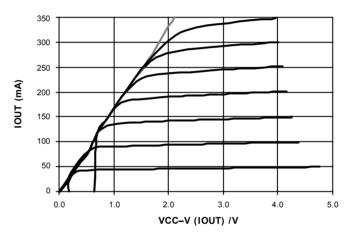
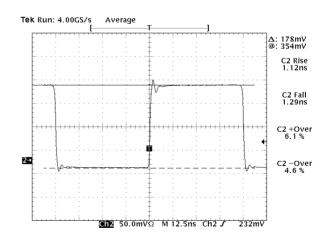


Figure 8. Step Response, Read Channel: 50 mA, Channel 2: 50 mApp

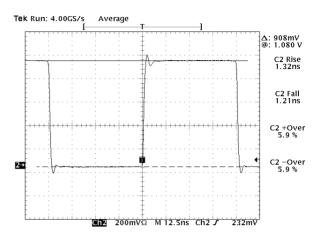


T0806

8

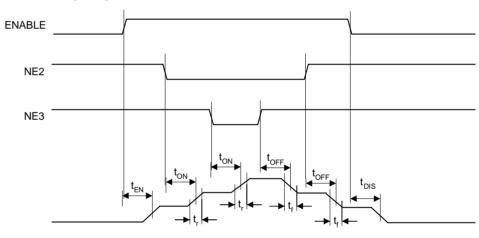
T0806





Timing Diagram

Figure 10. Timing Diagram of IOUTA/IOUTB

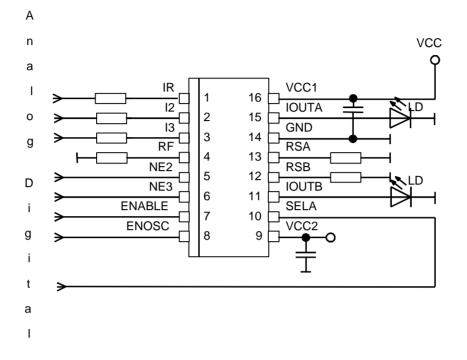






Typical Application Circuit

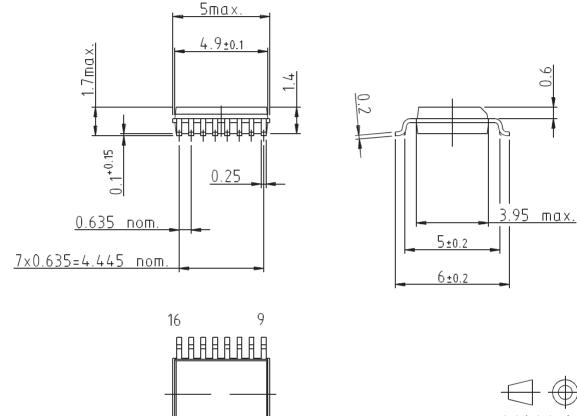
Figure 11. Application Circuit



Ordering Information

Extended Type Number	Package	Remarks
T0806-TCQ	SSO16	Taped and reeled

Package Information



1

8

technical drawings according to DIN specifications

S

 \subset

Drawing refers to following types: SS016 Package acc. JEDEC MO 137 AB

Drawing-No.: 6.543-5060.01-4 Issue: 2; 05.02.99





Atmel Headquarters

Corporate Headquarters 2325 Orchard Parkway San Jose, CA 95131 TEL 1(408) 441-0311 FAX 1(408) 487-2600

Europe

Atmel Sarl Route des Arsenaux 41 Case Postale 80 CH-1705 Fribourg Switzerland TEL (41) 26-426-5555 FAX (41) 26-426-5500

Asia

Room 1219 Chinachem Golden Plaza 77 Mody Road Tsimhatsui East Kowloon Hong Kong TEL (852) 2721-9778 FAX (852) 2722-1369

Japan

9F, Tonetsu Shinkawa Bldg. 1-24-8 Shinkawa Chuo-ku, Tokyo 104-0033 Japan TEL (81) 3-3523-3551 FAX (81) 3-3523-7581

Atmel Operations

Memory

2325 Orchard Parkway San Jose, CA 95131 TEL 1(408) 441-0311 FAX 1(408) 436-4314

Microcontrollers

2325 Orchard Parkway San Jose, CA 95131 TEL 1(408) 441-0311 FAX 1(408) 436-4314

La Chantrerie BP 70602 44306 Nantes Cedex 3, France TEL (33) 2-40-18-18-18 FAX (33) 2-40-18-19-60

ASIC/ASSP/Smart Cards

Zone Industrielle 13106 Rousset Cedex, France TEL (33) 4-42-53-60-00 FAX (33) 4-42-53-60-01

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906 TEL 1(719) 576-3300 FAX 1(719) 540-1759

Scottish Enterprise Technology Park Maxwell Building East Kilbride G75 0QR, Scotland TEL (44) 1355-803-000 FAX (44) 1355-242-743

RF/Automotive

Theresienstrasse 2 Postfach 3535 74025 Heilbronn, Germany TEL (49) 71-31-67-0 FAX (49) 71-31-67-2340

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906 TEL 1(719) 576-3300 FAX 1(719) 540-1759

Biometrics/Imaging/Hi-Rel MPU/

High Speed Converters/RF Datacom Avenue de Rochepleine BP 123 38521 Saint-Egreve Cedex, France TEL (33) 4-76-58-30-00 FAX (33) 4-76-58-34-80

e-mail literature@atmel.com

Web Site http://www.atmel.com

© Atmel Corporation 2003.

Atmel Corporation makes no warranty for the use of its products, other than those expressly contained in the Company's standard warranty which is detailed in Atmel's Terms and Conditions located on the Company's web site. The Company assumes no responsibility for any errors which may appear in this document, reserves the right to change devices or specifications detailed herein at any time without notice, and does not make any commitment to update the information contained herein. No licenses to patents or other intellectual property of Atmel are granted by the Company in connection with the sale of Atmel products, expressly or by implication. Atmel's products are not authorized for use as critical components in life support devices or systems.

Atmel[®] is the registered trademark of Atmel.

Other terms and product names may by the trademarks of others.

